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Mail Stop Amendment, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on September 16, 2005

William R. Allen, Reg. No. 48,389

Date

Applicants:

Toshiharu Furukawa et al.

Serial No.:

10/767,065

Filed:

January 29, 2004

Art Unit:

2811

Examiner:

Ori Nadav

Confirmation No.:

5663

Title:

VERTICAL NANOTUBE SEMICONDUCTOR DEVICE

STRUCTURES AND METHODS OF FORMING SAME

Atty Docket No.:

IBM-269

Cincinnati, Ohio 45202

September 16, 2005

PATENT

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the duty of candor and good faith imposed by 37 C.F.R. §1.56 and means of complying therewith according to 37 C.F.R. §\$1.97 and 1.98, the references listed on the attached Form PTO-1449 are called to the attention of the United States Patent and Trademark Office in connection with the above-identified patent application.

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Subject to the Office's waiver of providing copies of U.S. patents and published applications for applications filed after June 30, 2003, only foreign references and articles are provided, since this application was filed on January 29, 2004, and therefore, subsequent to June 30, 2003.

The Examiner is urged to consider all of the cited documents and to make an independent evaluation of the teachings and materiality of each.

Applicants also enclose a check in the amount of \$180.00 for this submission. If further fees are due, the Commissioner is authorized to charge deposit account 23-3000 for any required fees.

Respectfully submitted,

WOOD, HERRON & EVANS, L.L.P.

BY William R alle

William R. Allen Reg. No. 48,389

2700 Carew Tower 441 Vine Street Cincinnati, OH 45202 (513) 241-2324

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	A.R	Furukawa et al., <u>United States Patent Application Publication No. US 2005/O167740</u> , Publication Date: August 4, 2005														
	A.S	Furukawa et al., <u>United States Patent Application Publication No. US 2005/O179029</u> , Publication Date: August 18, 2005														
	A.T	Furukawa et al., <u>United States Patent Application Publication No. US 2005/O130341</u> , Publication Date: June 16, 2005														
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Sheet 2 (B) of 3 U.S. DEPARTMENT OF COMMERCE SERIAL NO. **SUBSTITUTE FORM PTO-1449** ATTY. DOCKET NO. PATENT AND TRADEMARK OFFICE 10/767,065 IBM/269 (MODIFIED) INFORMATION DISCLOSURE **APPLICANT** STATEMENT BY APPLICANT Toshiharu Furukawa et al. **GROUP FILING DATE** (Use several sheets if necessary) (37 CFR 1.98(b)) January 29, 2004 2811 **U.S. PATENT DOCUMENTS EXAMINER ISSUE** FILING DATE **SUBCLASS** IF APPROPRIATE INITIAL PATENT NUMBER DATE **PATENTEE CLASS** B.A B.B B.C B.D B.E B.F B.G B.H B.I B.J B.K FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS DOCUMENT **PUBLICATION COUNTRY OR** TRANSLATION PATENT OFFICE **SUBCLASS** NUMBER DATE **CLASS** (YES/NO) B.L

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DTHER DOCUMENTS (Including Author, Title, Date, Place of Publication)

B.R Furukawa et al., <u>United States Patent Application Publication No. US 2005/O129948</u>, Publication Date: June 16, 2005

B.S Dubin et al., <u>United States Patent Application Publication No. US 2005/O167755</u>, Publication Date: August 4, 2005

B.T Roesner et al., <u>United States Patent Application Publication No. US 2003/O132461</u>, Publication Date: July 17, 2003

EXAMINER DATE CONSIDERED

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